

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/551,655	AYABE, SHINICHI	AYABE, SHINICHI	
Examiner	Art Unit		
Vong D. Pak	1652		

SEARCHED					
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		